

# PMD3001D

MOSFET driver

Rev. 02 — 28 August 2009

Product data sheet

## 1. Product profile

### 1.1 General description

NPN/PNP transistor pair connected as push-pull driver in a SOT457 (SC-74) Surface-Mounted Device (SMD) plastic package.

### 1.2 Features

- Low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistors in push-pull configuration
- Application-optimized pinout
- Space-saving solution
- Internal connections to minimize layout effort
- Reduces component count

### 1.3 Applications

- MOSFET driver
- Power bipolar transistor driver
- Output current booster for operational amplifier

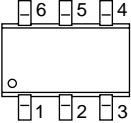
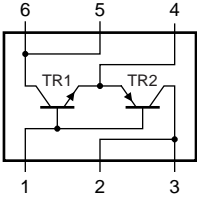
### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Per transistor; for the PNP transistor with negative polarity</b>						
$V_{CEO}$	collector-emitter voltage	open base	-	-	40	V
$I_C$	collector current		-	-	1	A
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	-	-	2	A

## 2. Pinning information

**Table 2. Pinning**

Pin	Description	Simplified outline	Symbol
1	base TR1, TR2		
2	collector TR2		
3	collector TR2		
4	emitter TR1, TR2		
5	collector TR1		
6	collector TR1		

*006aaa659*

## 3. Ordering information

**Table 3. Ordering information**

Type number	Package		
	Name	Description	Version
PMD3001D	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457

## 4. Marking

**Table 4. Marking codes**

Type number	Marking code
PMD3001D	9F

## 5. Limiting values

**Table 5. Limiting values**

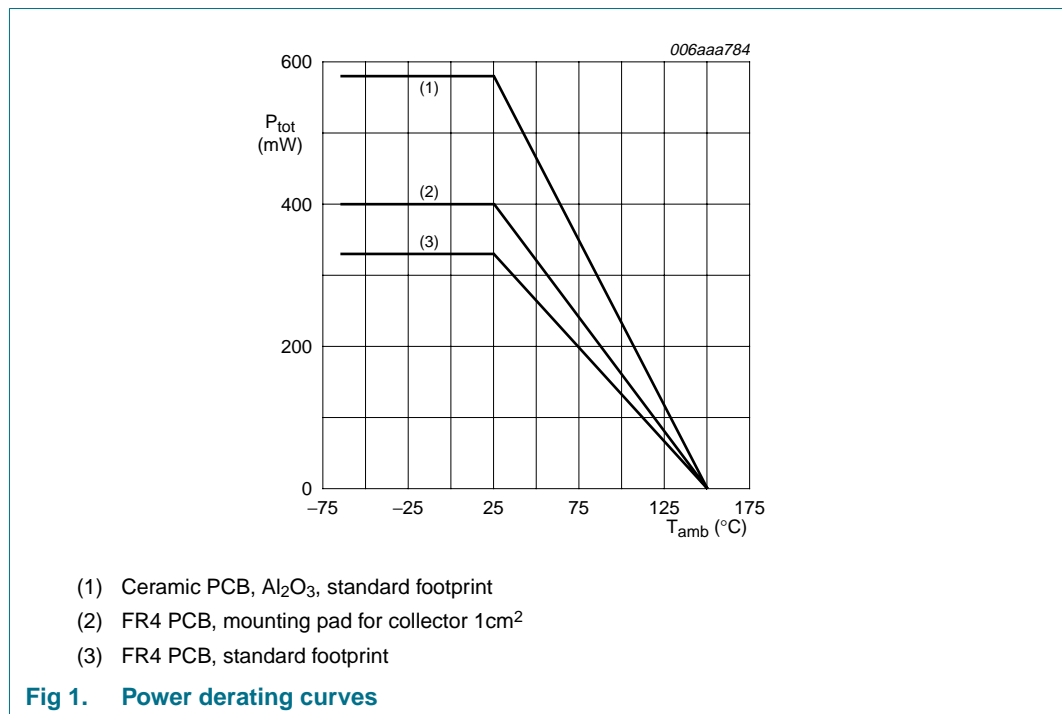
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit	
<b>Per transistor; for the PNP transistor with negative polarity</b>						
$V_{CBO}$	collector-base voltage	open emitter	-	40	V	
$V_{CEO}$	collector-emitter voltage	open base	-	40	V	
$I_C$	collector current		-	1	A	
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	-	2	A	
$I_{BM}$	peak base current		-	0.3	A	
		single pulse; $t_p \leq 1$ ms	-	1	A	
<b>Per device</b>						
$P_{tot}$	total power dissipation	$T_{amb} \leq 25$ °C	[1]	-	330	mW
			[2]	-	400	mW
			[3]	-	580	mW
$T_j$	junction temperature		-	150	°C	
$T_{amb}$	ambient temperature		-65	+150	°C	
$T_{stg}$	storage temperature		-65	+150	°C	

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

[3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



## 6. Thermal characteristics

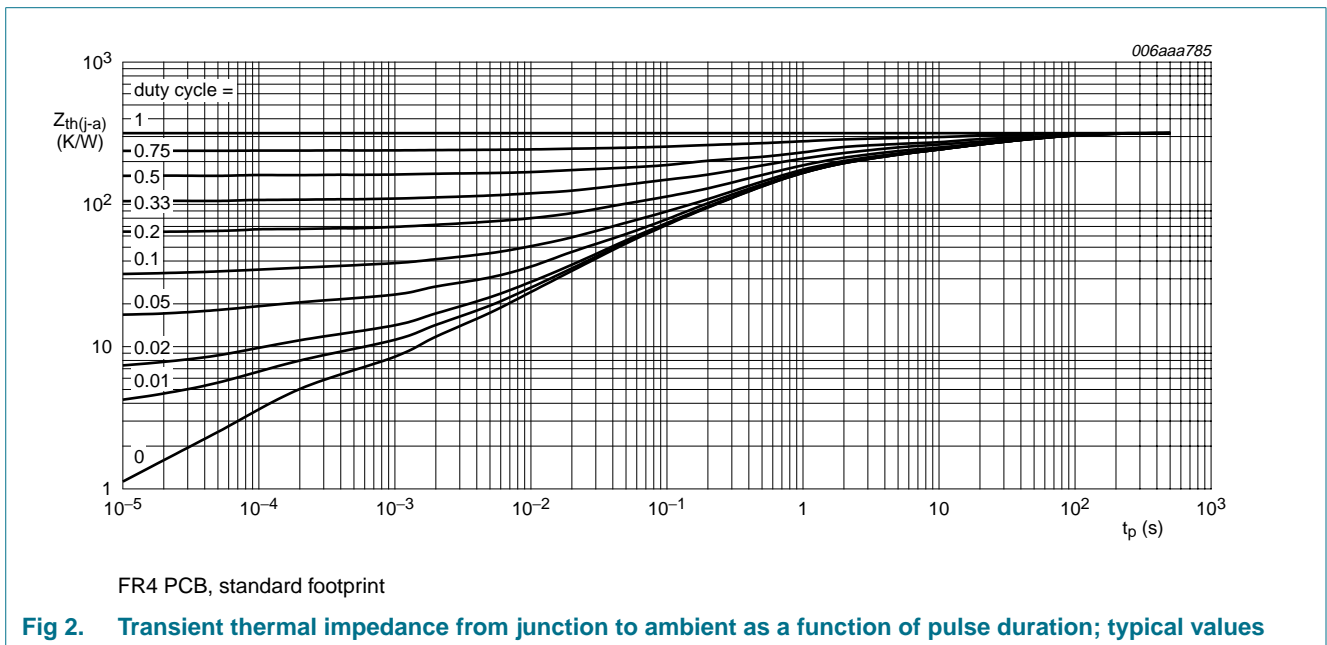
**Table 6. Thermal characteristics**

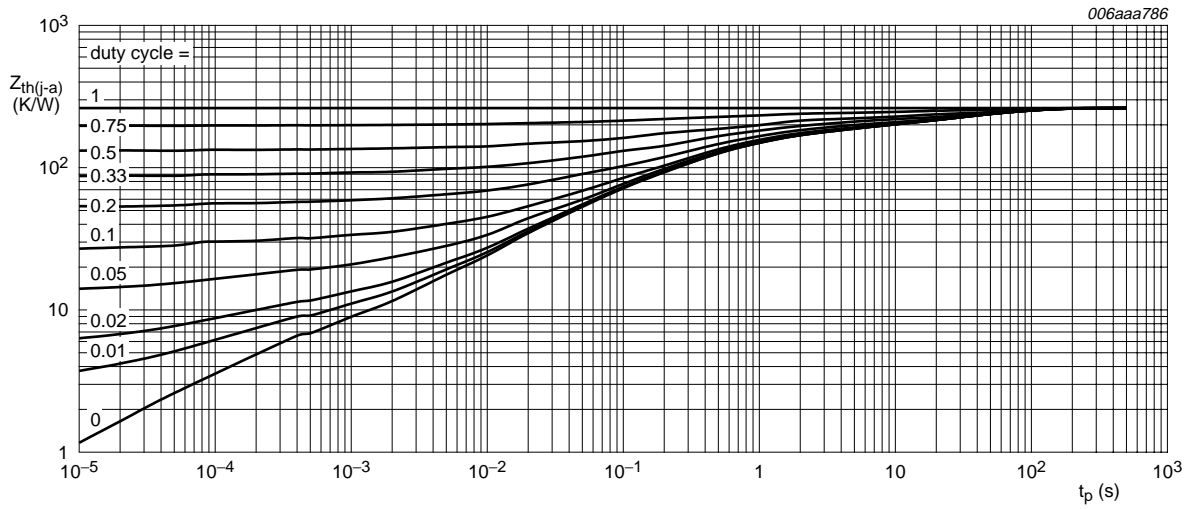
Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	-	380	K/W
			[2]	-	-	315	K/W
			[3]	-	-	215	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm<sup>2</sup>.

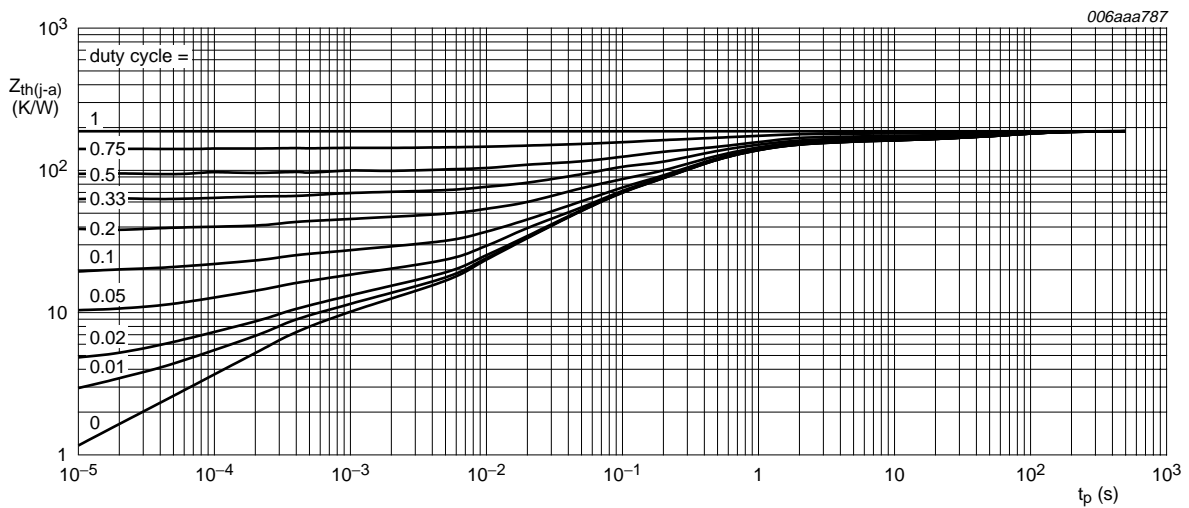
[3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.





FR4 PCB, mounting pad for collector 1cm<sup>2</sup>

**Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint

**Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**

## 7. Characteristics

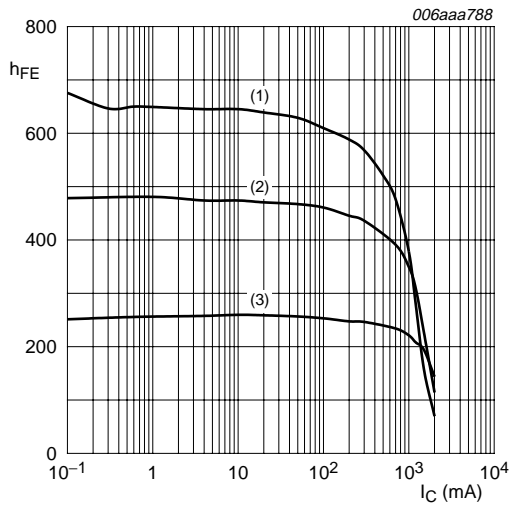
**Table 7. Characteristics**
*T<sub>amb</sub> = 25 °C unless otherwise specified*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
<b>Per NPN transistor</b>							
I <sub>CBO</sub>	collector-base cut-off current	V <sub>CB</sub> = 40 V; I <sub>E</sub> = 0 A	-	-	100	nA	
		V <sub>CB</sub> = 40 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C	-	-	50	μA	
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 5 V; I <sub>C</sub> = 1 mA	300	450	-		
		V <sub>CE</sub> = 5 V; I <sub>C</sub> = 200 mA	300	450	830		
		V <sub>CE</sub> = 5 V; I <sub>C</sub> = 500 mA	[1]	300	400	-	
		V <sub>CE</sub> = 5 V; I <sub>C</sub> = 1 A	[1]	200	340	-	
		V <sub>CE</sub> = 5 V; I <sub>C</sub> = 2 A	[1]	75	120	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	I <sub>C</sub> = 100 mA; I <sub>B</sub> = 5 mA	-	30	80	mV	
		I <sub>C</sub> = 500 mA; I <sub>B</sub> = 50 mA	[1]	-	100	120	mV
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 100 mA	[1]	-	180	230	mV
		I <sub>C</sub> = 2 A; I <sub>B</sub> = 200 mA	[1]	-	360	440	mV
V <sub>BEsat</sub>	base-emitter saturation voltage	I <sub>C</sub> = 100 mA; I <sub>B</sub> = 5 mA	-	0.75	0.9	V	
		I <sub>C</sub> = 500 mA; I <sub>B</sub> = 50 mA	[1]	-	0.9	1.1	V
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 100 mA	[1]	-	1	1.2	V
		I <sub>C</sub> = 2 A; I <sub>B</sub> = 200 mA	[1]	-	1.1	1.3	V
V <sub>BE</sub>	base-emitter voltage	V <sub>CE</sub> = 5 V; I <sub>C</sub> = 1 A	700	800	1100	mV	
<b>Per PNP transistor</b>							
I <sub>CBO</sub>	collector-base cut-off current	V <sub>CB</sub> = -40 V; I <sub>E</sub> = 0 A	-	-	-100	nA	
		V <sub>CB</sub> = -40 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C	-	-	-50	μA	
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = -5 V; I <sub>C</sub> = -1 mA	300	450	-		
		V <sub>CE</sub> = -5 V; I <sub>C</sub> = -200 mA	250	390	640		
		V <sub>CE</sub> = -5 V; I <sub>C</sub> = -500 mA	[1]	215	290	-	
		V <sub>CE</sub> = -5 V; I <sub>C</sub> = -1 A	[1]	150	200	-	
		V <sub>CE</sub> = -5 V; I <sub>C</sub> = -2 A	[1]	50	85	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	I <sub>C</sub> = -100 mA; I <sub>B</sub> = -5 mA	-	-40	-140	mV	
		I <sub>C</sub> = -500 mA; I <sub>B</sub> = -50 mA	[1]	-	-110	-170	mV
		I <sub>C</sub> = -1 A; I <sub>B</sub> = -100 mA	[1]	-	-200	-310	mV
		I <sub>C</sub> = -2 A; I <sub>B</sub> = -200 mA	[1]	-	-400	-500	mV
V <sub>BEsat</sub>	base-emitter saturation voltage	I <sub>C</sub> = -100 mA; I <sub>B</sub> = -5 mA	-	-0.75	-0.9	V	
		I <sub>C</sub> = -500 mA; I <sub>B</sub> = -50 mA	[1]	-	-0.88	-1.1	V
		I <sub>C</sub> = -1 A; I <sub>B</sub> = -100 mA	[1]	-	-0.95	-1.2	V
		I <sub>C</sub> = -2 A; I <sub>B</sub> = -200 mA	[1]	-	-1.1	-1.3	V
V <sub>BE</sub>	base-emitter voltage	V <sub>CE</sub> = -5 V; I <sub>C</sub> = -1 A	-700	-800	-1100	mV	

**Table 7. Characteristics ...continued**  
*T<sub>amb</sub> = 25 °C unless otherwise specified*

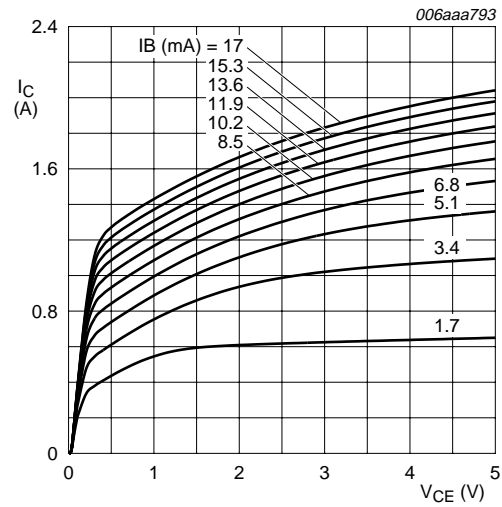
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Per device</b>						
t <sub>d</sub>	delay time	I <sub>C</sub> = 0.5 A; V <sub>I</sub> = 8 V	-	3	-	ns
t <sub>r</sub>	rise time		-	17	-	ns
t <sub>on</sub>	turn-on time		-	20	-	ns
t <sub>s</sub>	storage time		-	3	-	ns
t <sub>f</sub>	fall time		-	6	-	ns
t <sub>off</sub>	turn-off time		-	9	-	ns

[1] Pulse test: t<sub>p</sub> ≤ 300 μs; δ ≤ 0.02



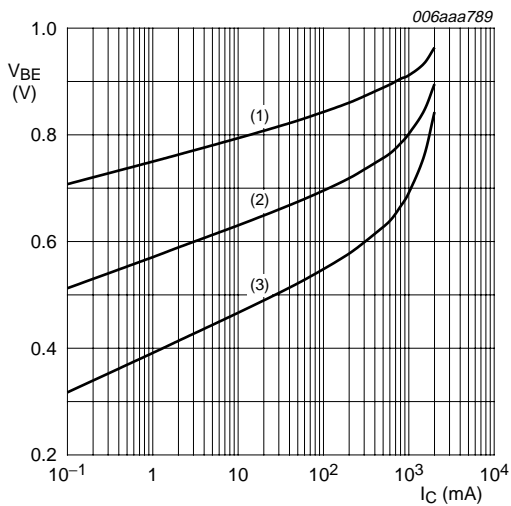
$V_{CE} = 5\text{ V}$   
 (1)  $T_{amb} = 100\text{ }^{\circ}\text{C}$   
 (2)  $T_{amb} = 25\text{ }^{\circ}\text{C}$   
 (3)  $T_{amb} = -55\text{ }^{\circ}\text{C}$

**Fig 5. TR1 (NPN): DC current gain as a function of collector current; typical values**



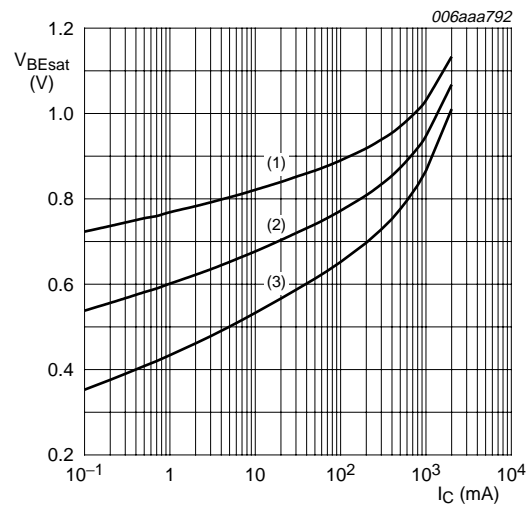
$T_{amb} = 25\text{ }^{\circ}\text{C}$

**Fig 6. TR1 (NPN): Collector current as a function of collector-emitter voltage; typical values**



$V_{CE} = 5\text{ V}$   
 (1)  $T_{amb} = -55\text{ }^{\circ}\text{C}$   
 (2)  $T_{amb} = 25\text{ }^{\circ}\text{C}$   
 (3)  $T_{amb} = 100\text{ }^{\circ}\text{C}$

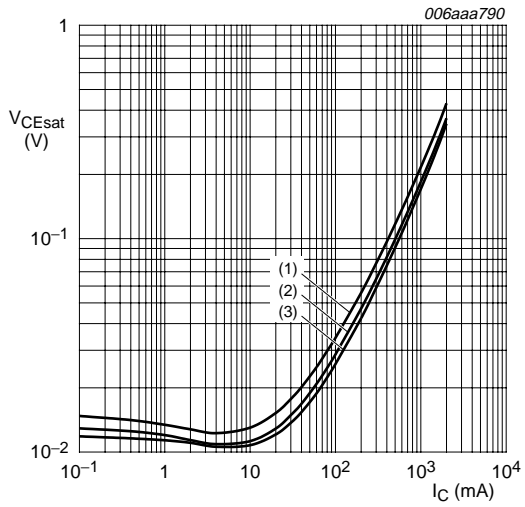
**Fig 7. TR1 (NPN): Base-emitter voltage as a function of collector current; typical values**



$I_C/I_B = 20$   
 (1)  $T_{amb} = -55\text{ }^{\circ}\text{C}$   
 (2)  $T_{amb} = 25\text{ }^{\circ}\text{C}$   
 (3)  $T_{amb} = 100\text{ }^{\circ}\text{C}$

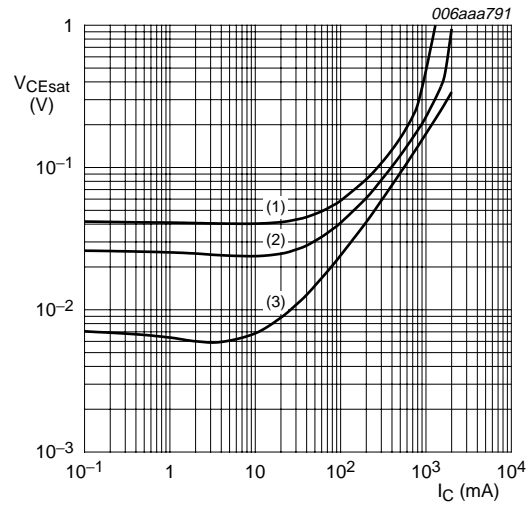
**Fig 8. TR1 (NPN): Base-emitter saturation voltage as a function of collector current; typical values**





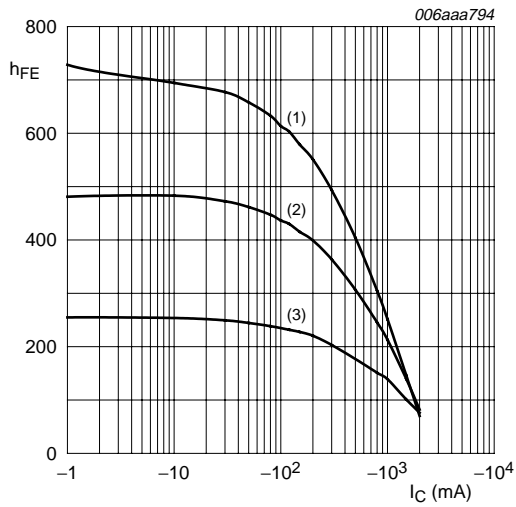
- $I_C/I_B = 20$
- (1)  $T_{amb} = 100\text{ °C}$
  - (2)  $T_{amb} = 25\text{ °C}$
  - (3)  $T_{amb} = -55\text{ °C}$

**Fig 9. TR1 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values**



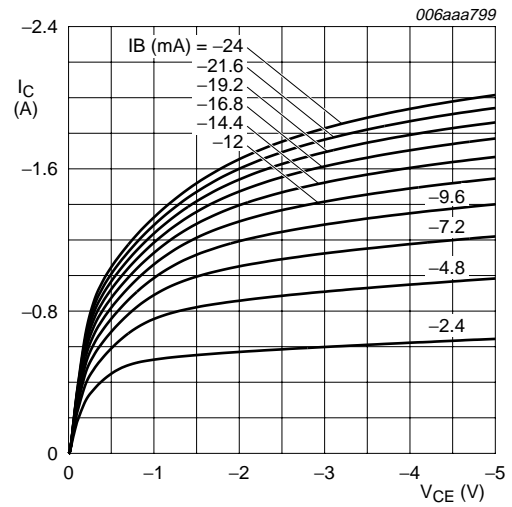
- $T_{amb} = 25\text{ °C}$
- (1)  $I_C/I_B = 100$
  - (2)  $I_C/I_B = 50$
  - (3)  $I_C/I_B = 10$

**Fig 10. TR1 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values**



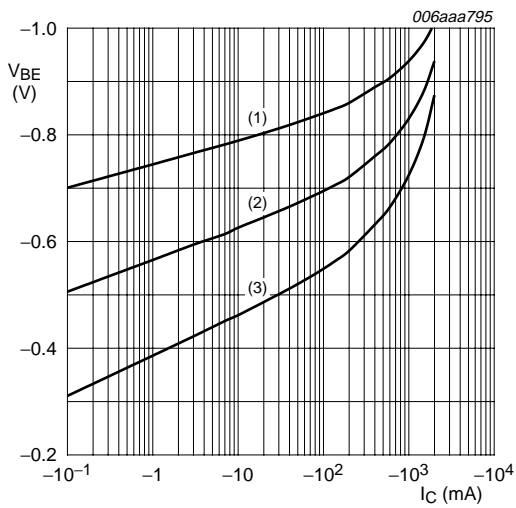
$V_{CE} = -5\text{ V}$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 11. TR2 (PNP): DC current gain as a function of collector current; typical values**



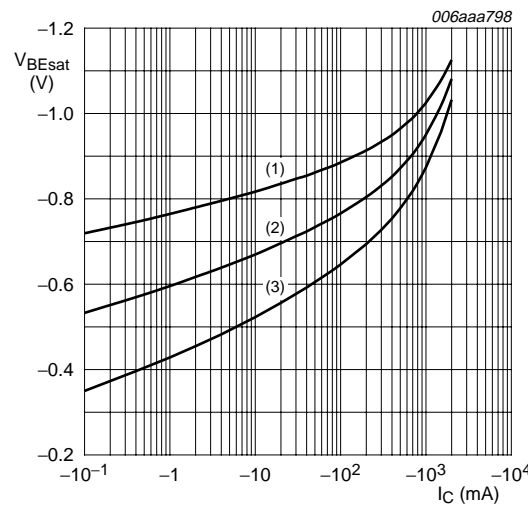
$T_{amb} = 25\text{ °C}$

**Fig 12. TR2 (PNP): Collector current as a function of collector-emitter voltage; typical values**



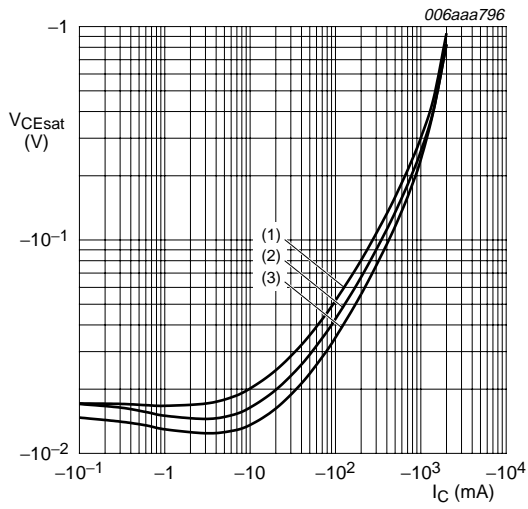
$V_{CE} = -5\text{ V}$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

**Fig 13. TR2 (PNP): Base-emitter voltage as a function of collector current; typical values**



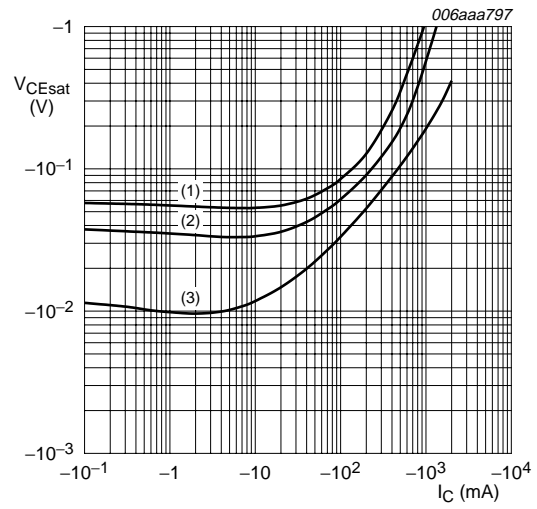
$I_C/I_B = 20$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

**Fig 14. TR2 (PNP): Base-emitter saturation voltage as a function of collector current; typical values**



- $I_C/I_B = 20$
- (1)  $T_{amb} = 100\text{ °C}$
  - (2)  $T_{amb} = 25\text{ °C}$
  - (3)  $T_{amb} = -55\text{ °C}$

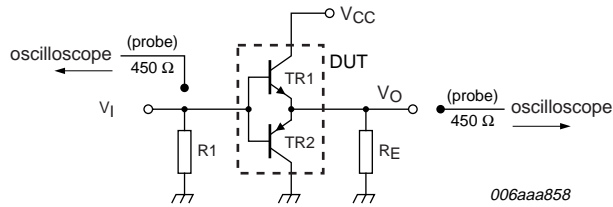
**Fig 15. TR2 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values**



- $T_{amb} = 25\text{ °C}$
- (1)  $I_C/I_B = 100$
  - (2)  $I_C/I_B = 50$
  - (3)  $I_C/I_B = 10$

**Fig 16. TR2 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values**

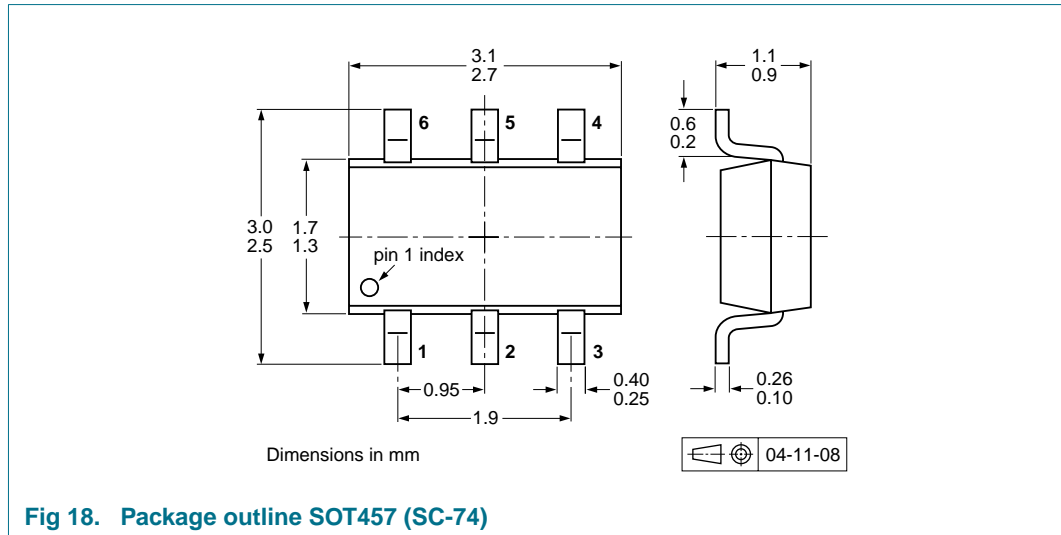
## 8. Test information



$I_C = 0.5\text{ A}; V_I = 8\text{ V}; R_1 = 56\text{ }\Omega; R_E = 15\text{ }\Omega$

**Fig 17. Test circuit for switching times**

## 9. Package outline



## 10. Packing information

**Table 8. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

Type number	Package	Description	Packing quantity	
			3000	10000
PMD3001D	SOT457	4 mm pitch, 8 mm tape and reel; T1 <sup>[2]</sup>	-115	-135
		4 mm pitch, 8 mm tape and reel; T2 <sup>[3]</sup>	-125	-165

[1] For further information and the availability of packing methods, see [Section 14](#).

[2] T1: normal taping

[3] T2: reverse taping

11. Soldering

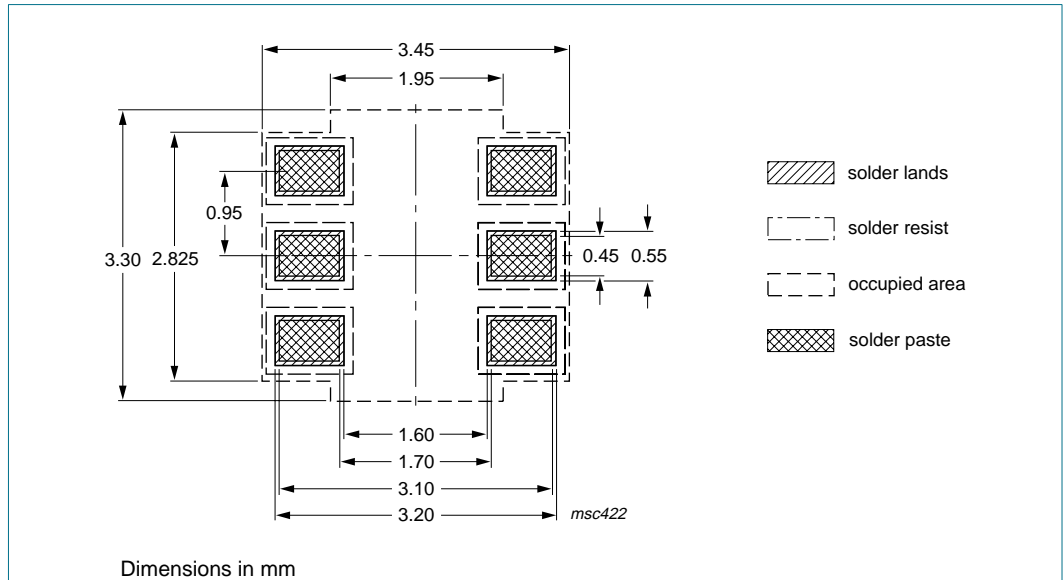


Fig 19. Reflow soldering footprint SOT457 (SC-74)

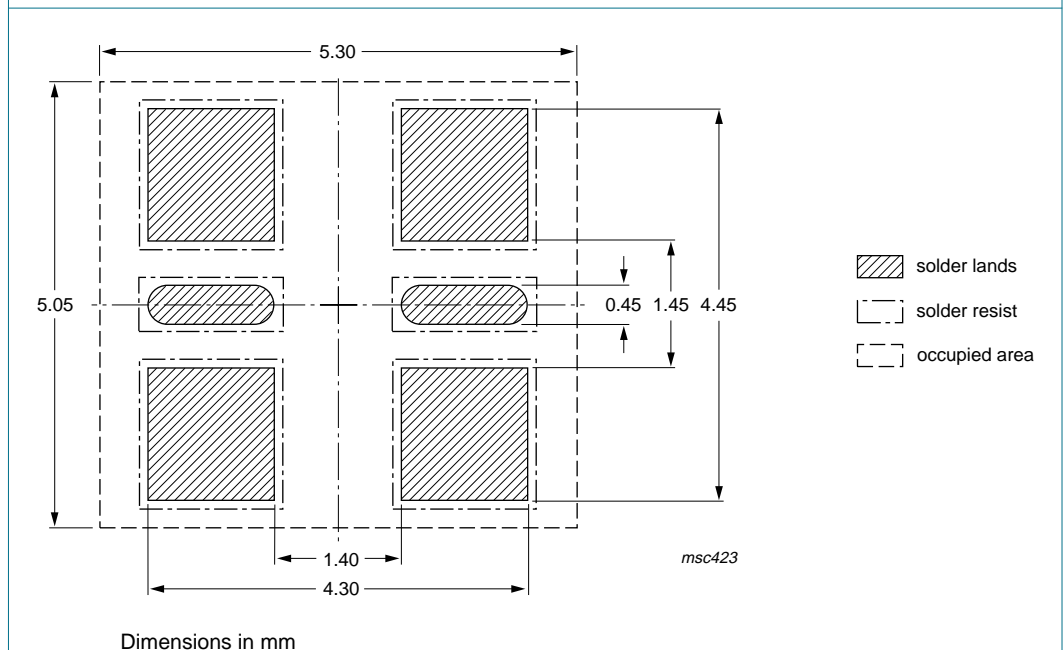


Fig 20. Wave soldering footprint SOT457 (SC-74)

## 12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMD3001D_2	20090828	Product data sheet	-	PMD3001D_1
Modifications:		<ul style="list-style-type: none"><li>This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content.</li><li><a href="#">Figure 20 "Wave soldering footprint SOT457 (SC-74)": updated</a></li></ul>		
PMD3001D_1	20060926	Product data sheet	-	-

## 13. Legal information

### 13.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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